



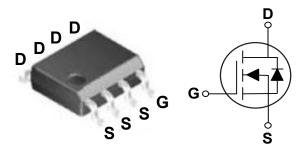
#### **General Description**

The S8MNM024 is the high cell density trenched N-ch MOSFETs, which provides excellent  $R_{\text{DSON}}$  and gate charge for most of the synchronous buck converter applications.

The S8MNM024 meets the RoHS and Green Product requirement with full function reliability approved.

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
100 V	24 mΩ	8 A

#### SOP-8 Pin Configuration



#### **Features**

- · Super Low Gate Charge
- · Green Device Available
- · Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

#### Absolute Maximum Ratings T<sub>C</sub>=25°C unless otherwise noted **Symbol Parameter** Rating Units $V_{DS}$ Drain-Source Voltage 100 $V_{GS}$ Gate-Source Voltage ±20 ٧ Drain Current - Continuous (T<sub>A</sub>=25°C) 8 Α $I_{\mathsf{D}}$ 6.6 Drain Current - Continuous (T<sub>A</sub>=100°C) Α $\mathbf{I}_{\mathrm{DM}}$ Drain Current - Pulsed (NOTE 1) 32 Α EAS 29 Single Pulse Avalanche Energy (NOTE 2) mJ IAS Avalanche Current 24 Α $P_D$ 2.7 Total Power Dissipation (T<sub>A</sub>=25°C) (NOTE 3) W $T_{\mathsf{J}}$ Operating Junction Temperature Range -50 to 150 ٥С $T_{STG}$ -50 to 150 Storage Temperature Range ٥С S0032, NM024 Marking Code

Thermal Characteristics					
Symbol	Parameter	Тур.	Max	Unit	
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Steady State)		80	°C/W	





#### Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , $I_D$ =250uA	100			V
I <sub>DSS</sub>	IDrain-Source Leakage Current	$V_{DS}$ =80V , $V_{GS}$ =0V , $T_{J}$ =25°C			1	uA
		$V_{DS}$ =80V , $V_{GS}$ =0V , $T_{J}$ =55 $^{\circ}$ C			5	uA
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA

#### On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
	Static Drain-Source On-Resistance	$V_{GS}$ =10V , $I_D$ =8A		20	24	mΩ
T <sub>DS(ON)</sub>	(NOTE 1)	V <sub>GS</sub> =4.5V , I <sub>D</sub> =4A		23	28	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250uA$	1.2		2.5	V

#### **Dynamic and switching Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$Q_g$	Total Gate Charge			57		
$Q_gs$	Gate-Source Charge	$V_{DS}$ =30V , $V_{GS}$ =10V , $I_{D}$ =8A		8.7		nC
$Q_{gd}$	Gate-Drain Charge			14		
$T_{d(on)}$	Turn-On Delay Time			16.2		
$T_r$	Rise Time	$V_{DD}$ =30V , $V_{GS}$ =10V , $R_{G}$ =3.3 $\Omega$		41.2		no
$T_{d(off)}$	Turn-Off Delay Time	, I <sub>D</sub> =1A		56.4		ns
$T_f$	Fall Time			16.2		
$C_{iss}$	Input Capacitance			3307		
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =25V , $V_{GS}$ =0V , F=1MHz		201		pF
$C_{rss}$	Reverse Transfer Capacitance			151		

#### **Drain-Source Diode Characteristics and Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current (NOTE 4)	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	-		8	Α
$V_{SD}$	Diode Forward Voltage (NOTE 1)	$V_{GS}$ =0V , $I_{S}$ =1A , $T_{J}$ =25 $^{\circ}$ C			1.2	V
trr	Reverse Recovery Time	I <sub>F</sub> =8A,di/dt=100A/us,		44		ns
Qrr	Reverse Recovery Charge	T <sub>J</sub> =25°C		25		nC

#### NOTES:

- 1. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 2. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V, $V_{GS}$ =10V,L=0.1mH, $I_{AS}$ =24A
- 3. The power dissipation is limited by 150  $\!\!\!\!\!^{\circ}_{\circ}$  junction temperature
- 4. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



# Pb RoHS

# 100V N-Channel MOSFETs

#### **Characteristics Curves**

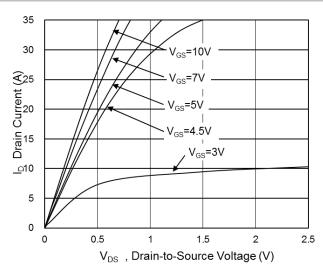


Fig.1 Typical Output Characteristics

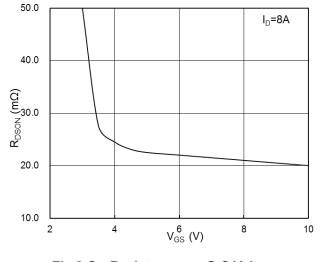


Fig.2 On-Resistance vs. G-S Voltage

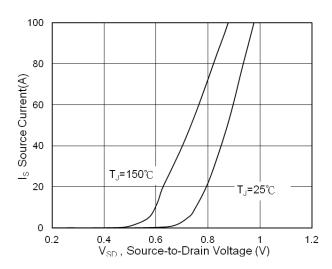


Fig.3 Source-Drain Diode Forward Voltage

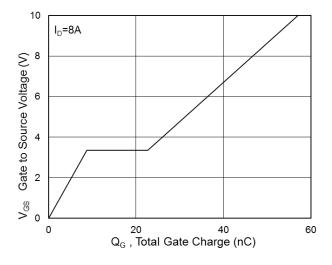


Fig.4 Gate-Charge Characteristics

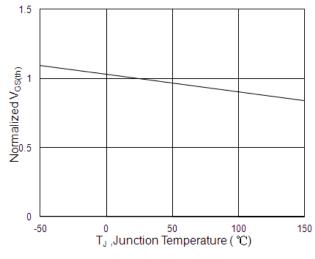


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$ 

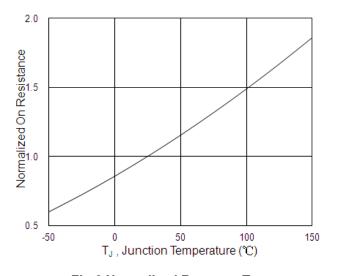
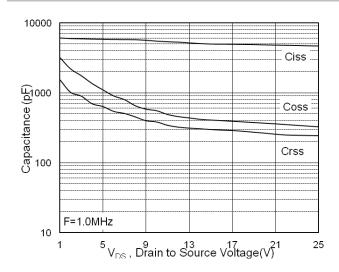


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>





#### **Characteristics Curves**



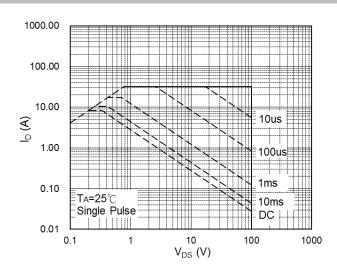


Fig.7 Capacitance

Fig.8 Safe Operating Area

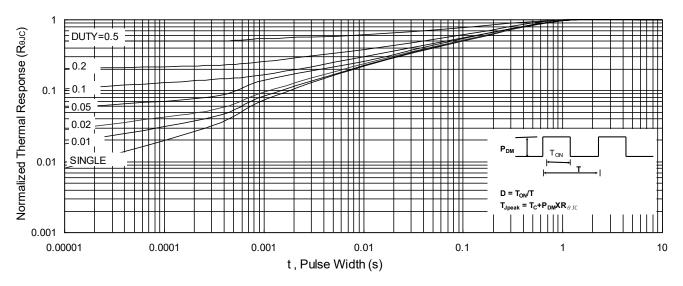


Fig.9 Normalized Maximum Transient Thermal Impedance

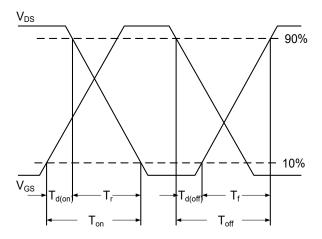
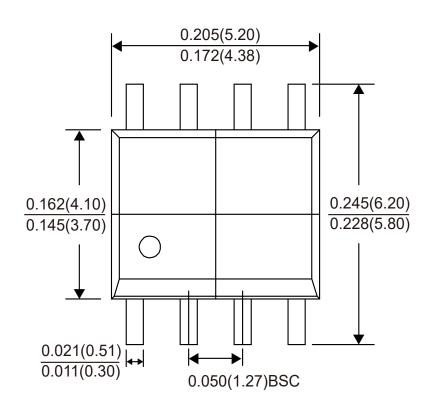


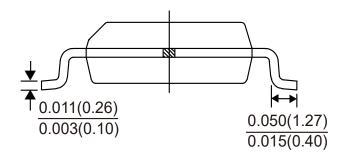
Fig.10 Switching Time Waveform

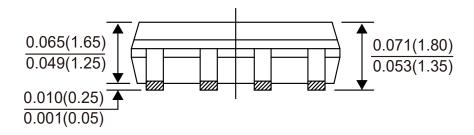




#### **Package Outline Dimensions**







**SOP-8**Dimensions in inches and (millimeters)





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